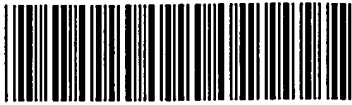


Search Notes

Application/Control No.

09/595,288

Examiner

Cong-Lac Huynh

Applicant(s)/Patent under
Reexamination

FIEDOROWICZ ET AL.

Art Unit

2178

SEARCHED

Class	Subclass	Date	Examiner
715	513	6/19/2006	CLH
	500	6/19/2006	CLH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	6/19/2006	CLH
ACM	6/19/2006	CLH
IEEE	6/19/2006	CLH